Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,777	ITANO ET AL.
Examiner	Art Unit
Stephen M. Hepperle	3753

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SEARCHED				
Class	Subclass	Date	Examiner	
137	68.3 I 505.13 . 505.15 .	5/07	9M	
1998	495 x 505.28x 505.41x			
169	19 x			
- 6	20			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		5/07	
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